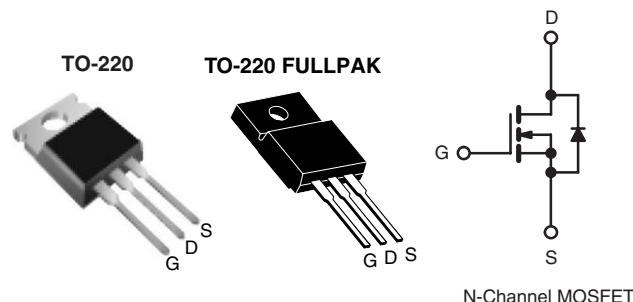


Power MOSFET

PRODUCT SUMMARY	
V _{DS} (V) at T _J max.	560
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.225
Q _g (Max.) (nC)	76
Q _{gs} (nC)	21
Q _{gd} (nC)	29
Configuration	Single



FEATURES

- Low Figure-of-Merit R_{on} x Q_g
- 100 % Avalanche Tested
- High Peak Current Capability
- dV/dt Ruggedness
- Improved t_{rr}/Q_{rr}
- Improved Gate Charge
- High Power Dissipations Capability
- Compliant to RoHS Directive 2002/95/EC



ORDERING INFORMATION		
Package	TO-220	TO-220 FULLPAK
Lead (Pb)-free	SiHP18N50C-E3	SiHF18N50C-E3

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	500	V
Gate-Source Voltage			V _{GS}	± 30	
Continuous Drain Current (T _J = 150 °C) ^a	V _{GS} at 10 V	T _C = 25 °C	I _D	18	A
		T _C = 100 °C		11	
Pulsed Drain Current ^b			I _{DM}	72	
Linear Derating Factor		TO-220		1.8	W/°C
		FULLPAK		0.3	
Single Pulse Avalanche Energy ^c			E _{AS}	361	mJ
Maximum Power Dissipation		TO-220	P _D	223	W
		FULLPAK		38	
Peak Diode Recovery dV/dt ^d			dV/dt	5	V/ns
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature) ^d	for 10 s			300	

Notes

- Drain current limited by maximum junction temperature.
- Repetitive rating; pulse width limited by maximum junction temperature.
- V_{DD} = 50 V, starting T_J = 25 °C, L = 2.5 mH, R_g = 25 Ω, I_{AS} = 17 A.
- I_{SD} ≤ 18 A, dI/dt ≤ 380 A/μs, V_{DD} ≤ V_{DS}, T_J ≤ 150 °C.
- 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	TO-220	R_{thJA}	-	62
	FULLPAK		-	65
Maximum Junction-to-Case (Drain)	TO-220	R_{thJC}	-	0.56
	FULLPAK		-	3.29

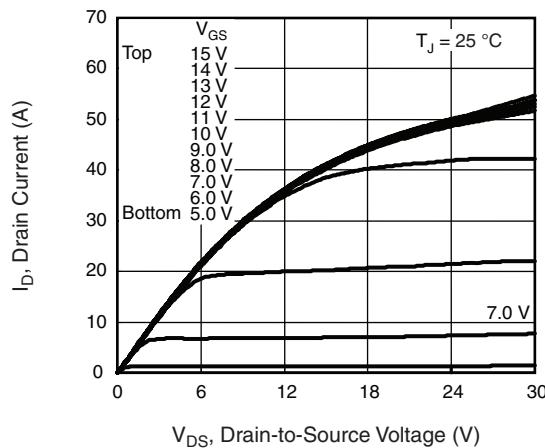
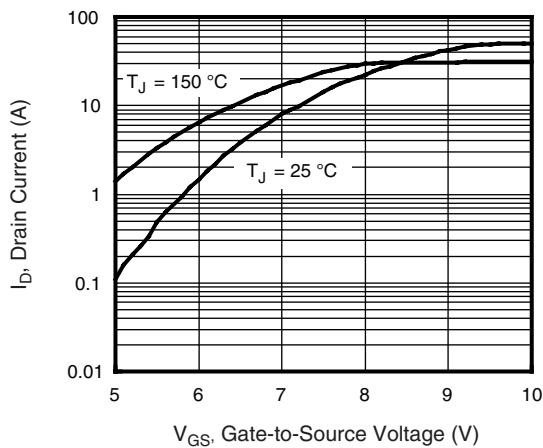
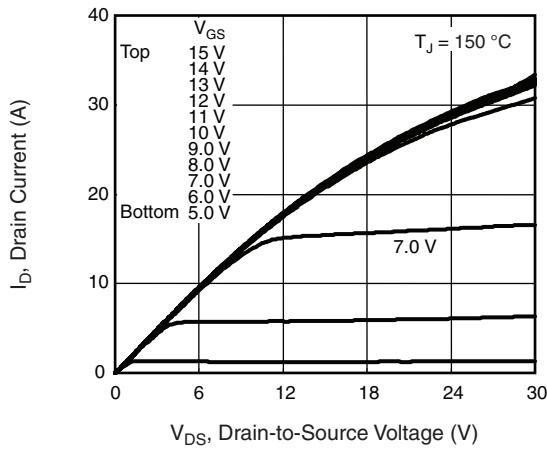
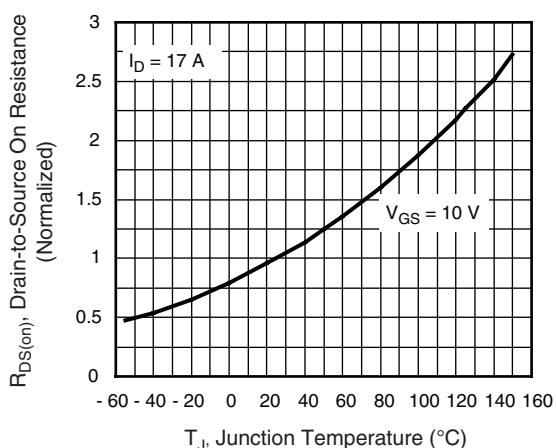
SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}$	$I_D = 250 \mu\text{A}$	500	-	-	V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25°C , $I_D = 1 \text{ mA}$		-	0.6	-	V°C
Gate-Source Threshold Voltage (N)	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$		3.0	-	5.0	V
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 30 \text{ V}$		-	-	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 500 \text{ V}$, $V_{GS} = 0 \text{ V}$		-	-	25	μA
		$V_{DS} = 400 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 125^\circ\text{C}$		-	-	250	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 10 \text{ A}$	-	0.225	0.270	Ω
Forward Transconductance ^a	g_{fs}	$V_{DS} = 50 \text{ V}$, $I_D = 10 \text{ A}$		-	6.4	-	S
Dynamic							
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1.0 \text{ MHz}$		-	2451	2942	pF
Output Capacitance	C_{oss}			-	300	360	
Reverse Transfer Capacitance	C_{rss}			-	26	32	
Internal Gate Resistance	R_g	$f = 1.0 \text{ MHz}$, open drain		-	1.1	-	Ω
Total Gate Charge	Q_g	$V_{GS} = 10 \text{ V}$	$I_D = 18 \text{ A}$, $V_{DS} = 400 \text{ V}$	-	65	76	nC
Gate-Source Charge	Q_{gs}			-	21	-	
Gate-Drain Charge	Q_{gd}			-	29	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 250 \text{ V}$, $I_D = 18 \text{ A}$ $R_g = 7.5 \Omega$, $V_{GS} = 10 \text{ V}$		-	80	-	ns
Rise Time	t_r			-	27	-	
Turn-Off Delay Time	$t_{d(off)}$			-	32	-	
Fall Time	t_f			-	44	-	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	18	A
Pulsed Diode Forward Current	I_{SM}			-	-	72	
Body Diode Voltage	V_{SD}	$T_J = 25^\circ\text{C}$, $I_S = 18 \text{ A}$, $V_{GS} = 0 \text{ V}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}$, $I_F = I_S$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $V_R = 35 \text{ V}$		-	503	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	6.7	-	
Reverse Recovery Current	I_{RRM}			-	30	-	A

Note

- a. Repetitive rating; pulse width limited by maximum junction temperature.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Fig. 1 - Typical Output Characteristics, $T_C = 150 \text{ }^{\circ}\text{C}$ (TO-220)

Fig. 3 - Typical Transfer Characteristics

Fig. 2 - Typical Output Characteristics, $T_C = 150 \text{ }^{\circ}\text{C}$ (TO-220)

Fig. 4 - Normalized On-Resistance vs. Temperature

SiHP18N50C, SiHF18N50C

Vishay Siliconix

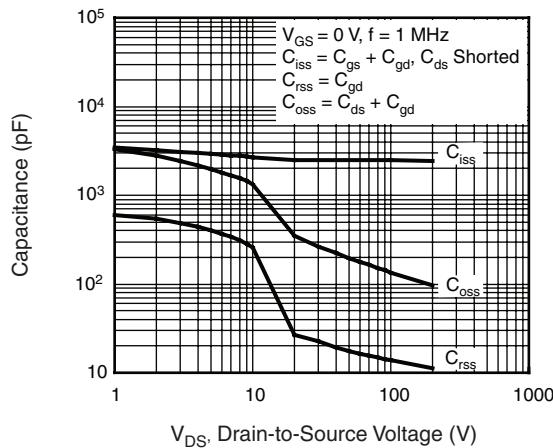


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

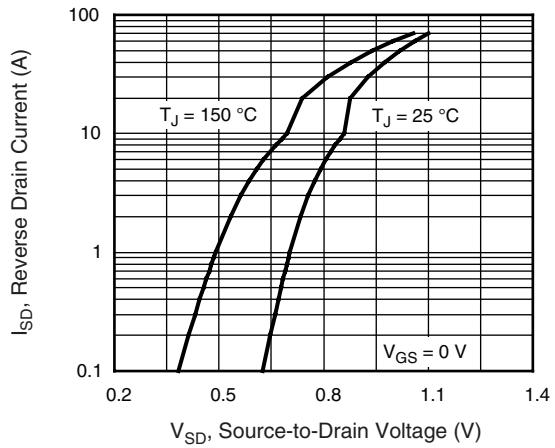


Fig. 7 - Typical Source-Drain Diode Forward Voltage

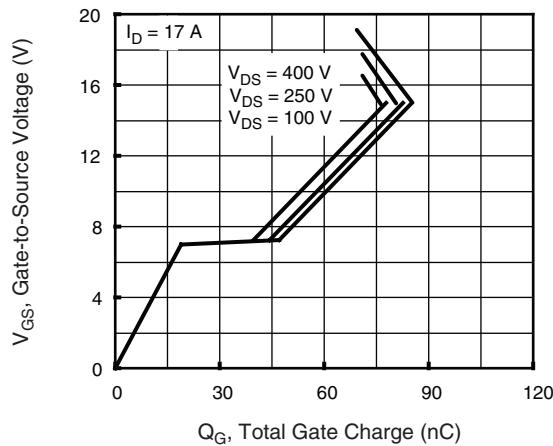


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

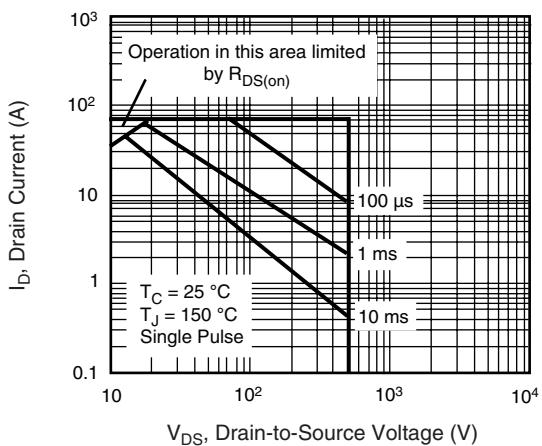


Fig. 8 - Maximum Safe Operating Area

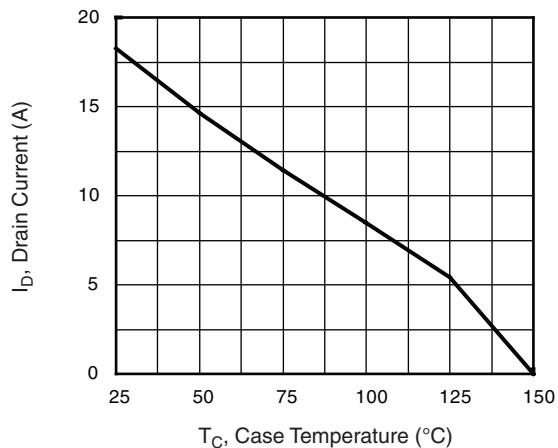


Fig. 9 - Maximum Drain Current vs. Case Temperature (TO-220)

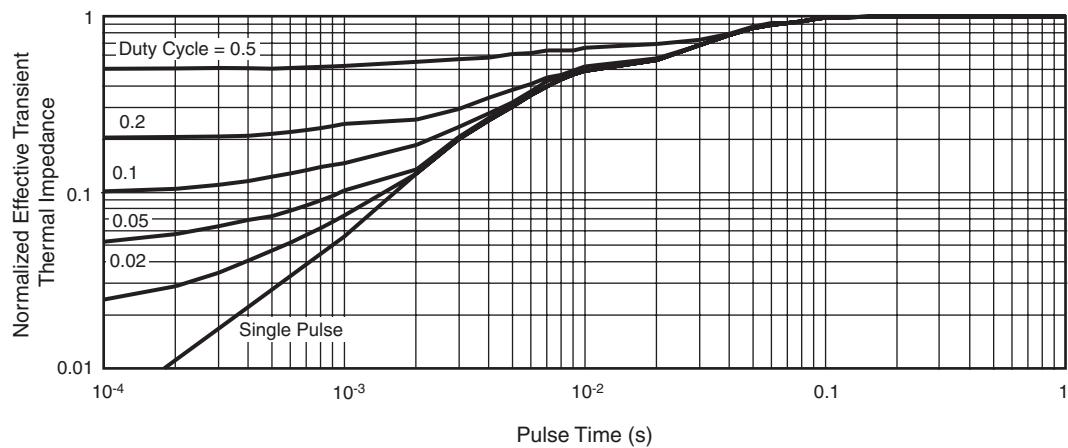


Fig. 10 - Normalized Thermal Transient Impedance, Junction-to-Case (TO-220)

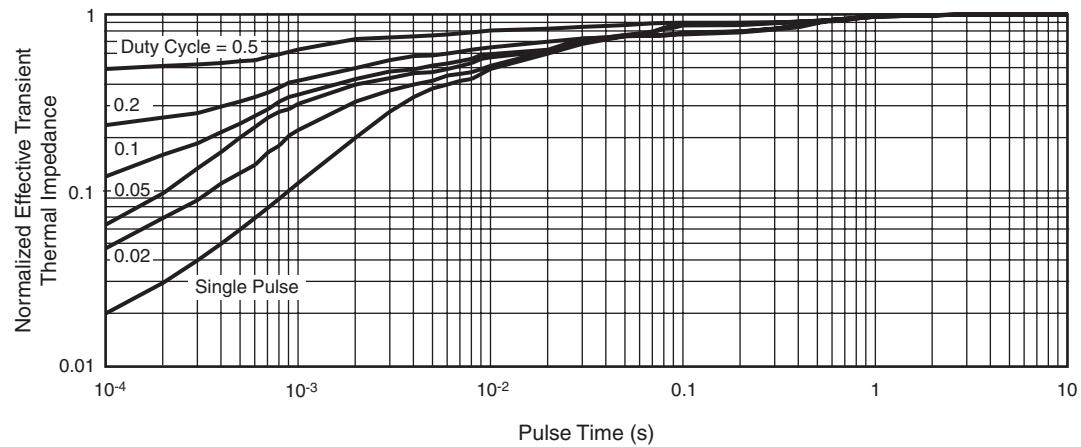


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case (TO-220FP)

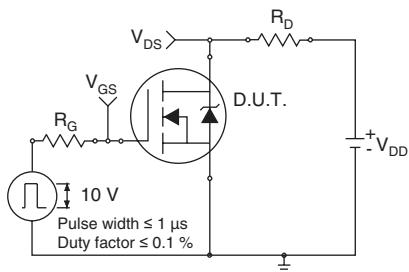


Fig. 12a - Switching Time Test Circuit

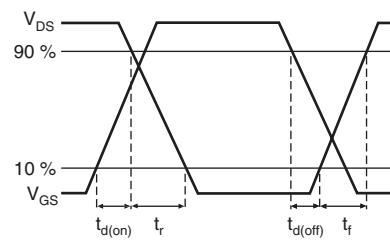


Fig. 12b - Switching Time Waveforms

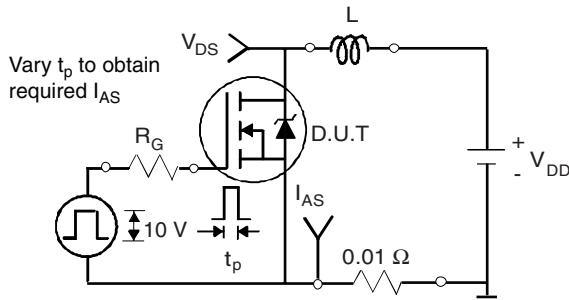


Fig. 13a - Unclamped Inductive Test Circuit

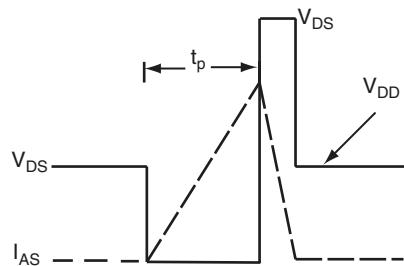


Fig. 13b - Unclamped Inductive Waveforms

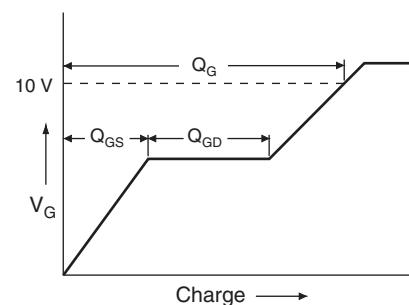


Fig. 14a - Basic Gate Charge Waveform

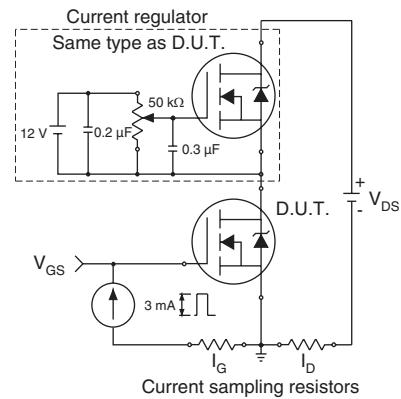
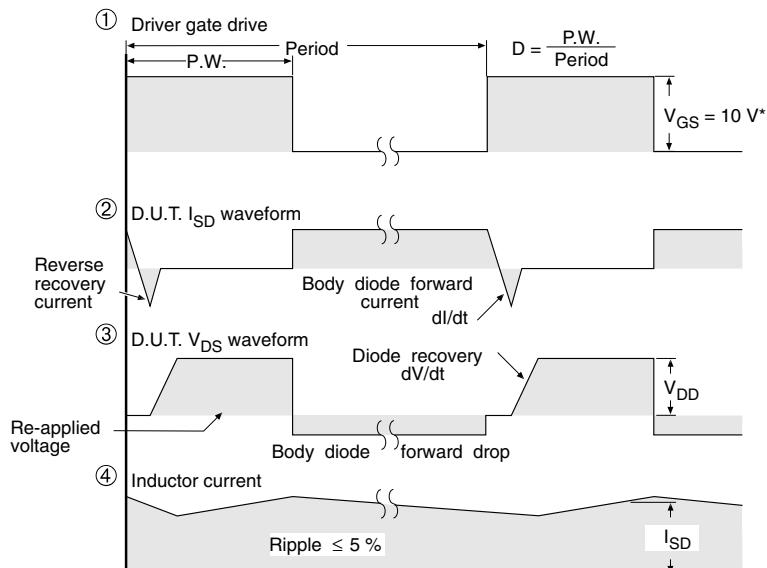
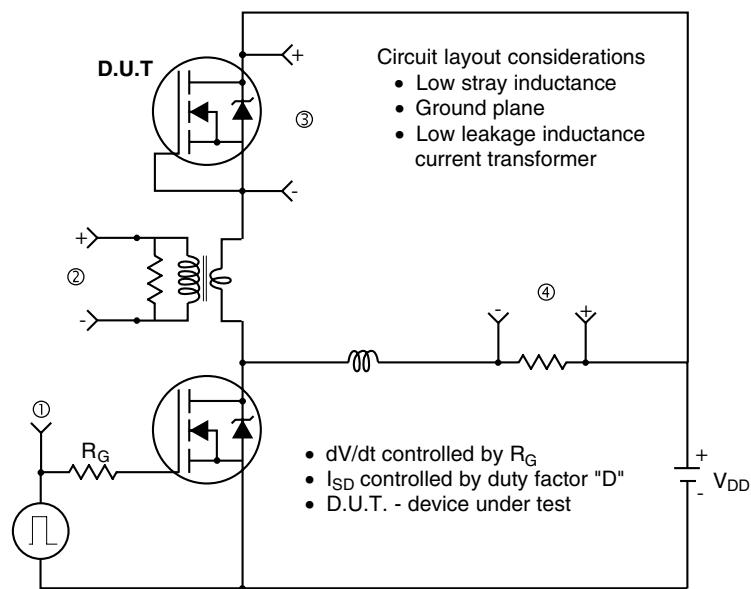


Fig. 14b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



* $V_{GS} = 5$ V for logic level and 3 V drive devices

Fig. 15 - For N-Channel

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